

Search Notes**Application/Control No.**

10/623,026

Examiner

Tuan V. Thai

Applicant(s)/Patent under Reexamination

LEE ET AL.

Art Unit

2186

SEARCHED

Class	Subclass	Date	Examiner
711	5	10/21/2005	TH
711	100	10/21/2005	TH
711	154	10/21/2005	TH
711	170	10/21/2005	TH
711	200	10/21/2005	TH

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
IEEE search; NPL search; EAST searches: IBMTDB DERWENTs EPO/JPO abstract USPGPUB NORHT database	1/31/2006	TH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner